


Focusing Optics: Additional Background Information

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QUB XRD Course

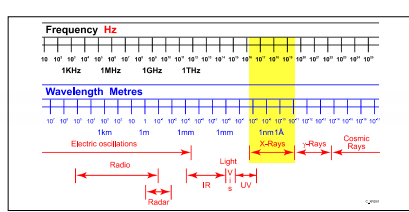
Focusing Optics



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What are X-rays?



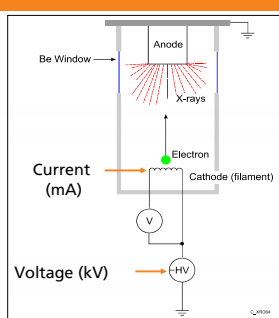
X-rays: electromagnetic radiation with a wavelength from 0.1 Å to 100 Å (0.01 nm to about 10 nm).

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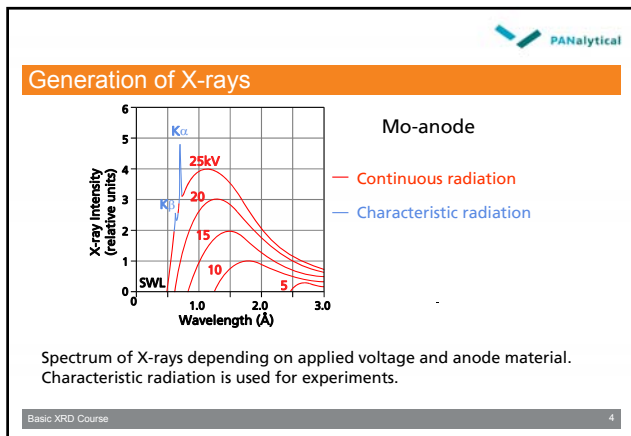
Generation of X-rays

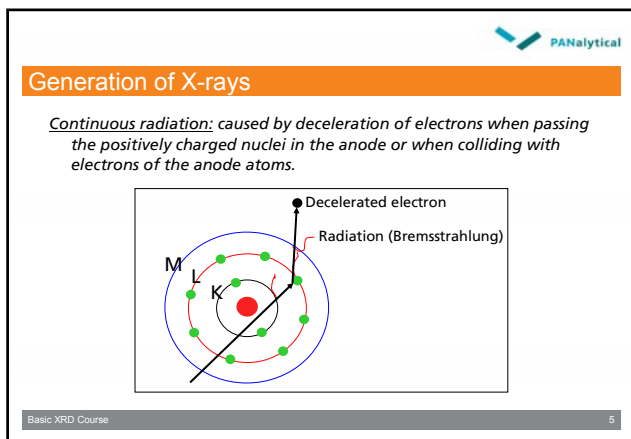
- Electrons are emitted by a hot filament
- High voltage accelerates electrons
- Electrons bombard anode material at high speed
- Kinetic energy of electrons largely transferred into heat and X-ray radiation

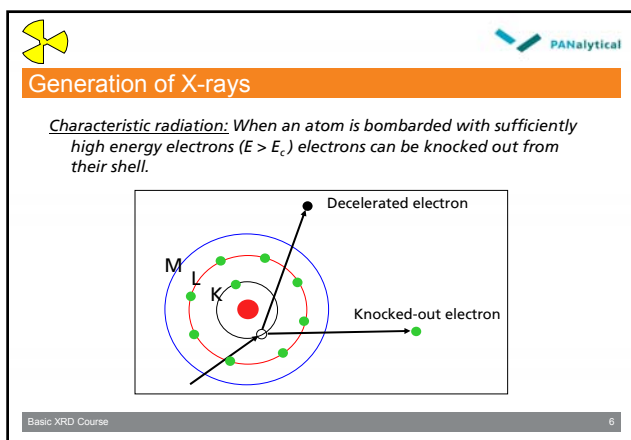


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Generation of X-rays

Characteristic radiation: An electron from a higher shell takes the place of the knocked-out electron. The energy difference between both shells is released in the form of X-ray radiation of a specific wavelength.

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Generation of X-rays

K_α and K_α₂ radiation:
 K_α radiation comprises two wavelengths: K_α₁ and K_α₂.
 The wavelengths correspond to the transitions from the L-shell to the K-shell. The L-shell has three energy levels from which level I is empty.

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X-ray Operation Conditions

Intensity of characteristic radiation:

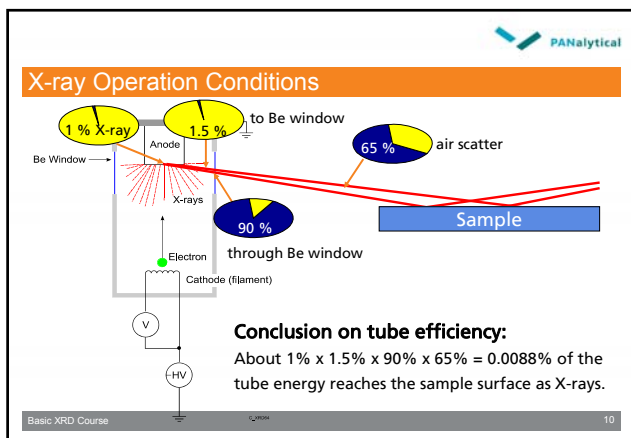
$$I(\lambda) = K \cdot mA \cdot (kV - V_c)^n$$

I = intensity
 K = constant
 V_c = critical voltage for characteristic radiation
 $n = 1.6$

In general: $kV = 3 \text{ to } 5 \times V_c$

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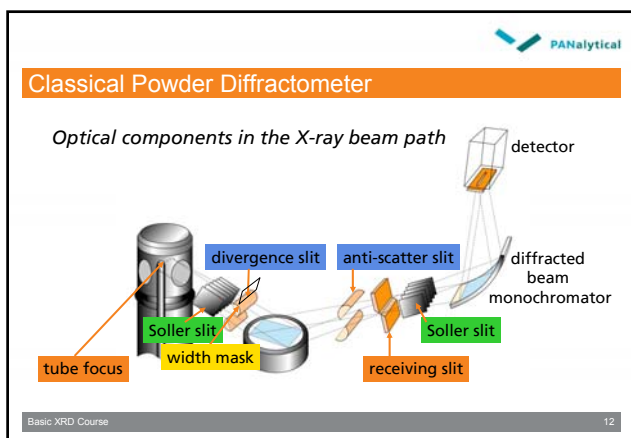



X-ray Operation Conditions

Anode material = choice of wavelength

Element	Symbol	K_{α} [nm]	Application
Chromium	Cr	0.2291	large unit cells (clays, organic materials, zeolites), steel (residual stress)
Iron	Fe	0.1937	matrix effects of Fe and Cr
Cobalt	Co	0.1791	ferro materials
Copper	Cu	0.1542	standard tube
Molybdenum	Mo	0.0710	single crystal, small unit cells (metals)
Silver	Ag	0.0561	high absorbing materials
Tungsten	W	0.0211	Laue camera (continuum needed)

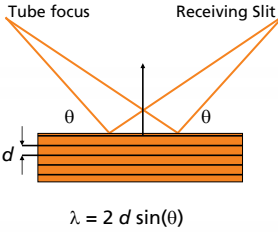
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Classical Powder Diffractometer

- Sample surface normal bisects incident and diffracted beams
- Diffracted beams focus at the same distance as the tube focus in receiving slit
- Optimal resolution



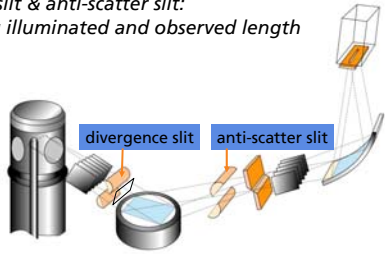
$\lambda = 2 d \sin(\theta)$

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Divergence Slit & Anti-scatter Slit

*Divergence slit & anti-scatter slit:
determining illuminated and observed length*



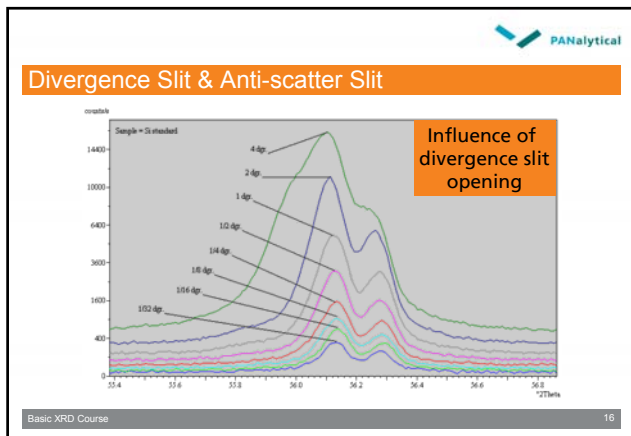
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Divergence Slit & Anti-scatter Slit

- Divergence slit determines the **irradiated** length on the sample
 - major effect on intensities
 - minor effect on resolution
- Anti-scatter slit determines **observed** length on the sample
 - used to reduce background
 - major effect on the peak-to-background ratio
 - ideally the observed area equals the illuminated area

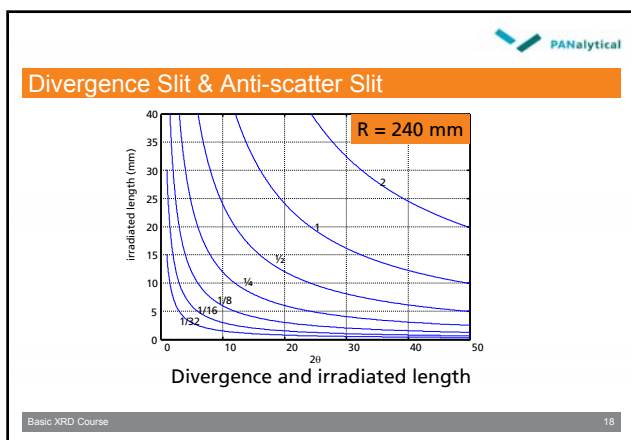
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Divergence Slit & Anti-scatter Slit

- The size of the divergence slit depends on the angular range (starting angle) and on the size of the sample.
- A smaller divergence slit gives a smaller illumination on the sample and less diffracted intensity.

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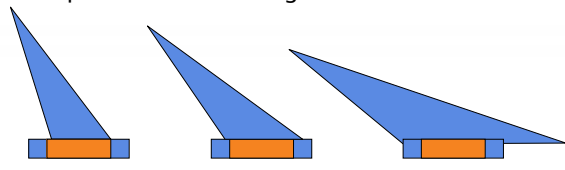


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If You Want to Gain Intensity....

- Make sure that you never over-irradiate the sample at low 2Theta angles...

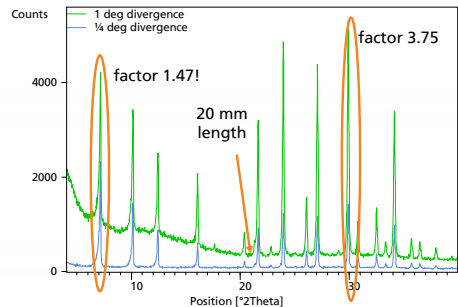


... it will give a very high background!

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Divergence Slit Size and Peak Intensities



Counts

— 1 deg divergence
— 1/4 deg divergence

4000

2000

0

10 20 30

Position (°2Theta)

20 mm length

factor 1.47!

factor 3.75

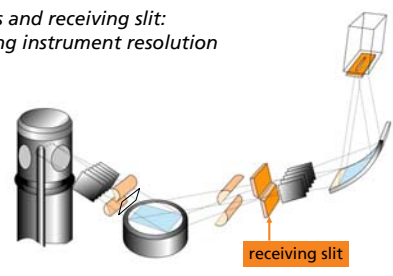
Hint:
you can observe the irradiated length on the status bar of the X'Pert Data Collector!

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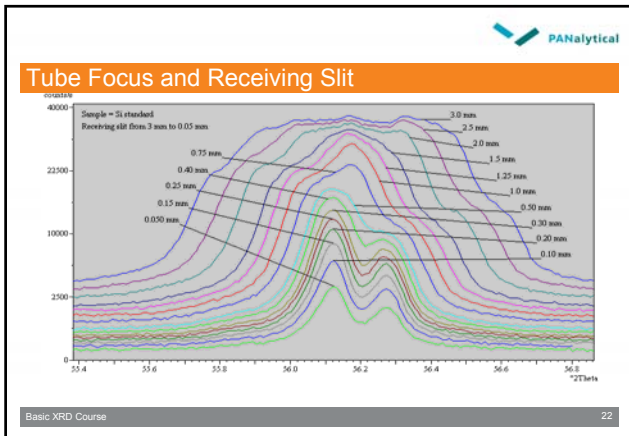
Receiving Slit

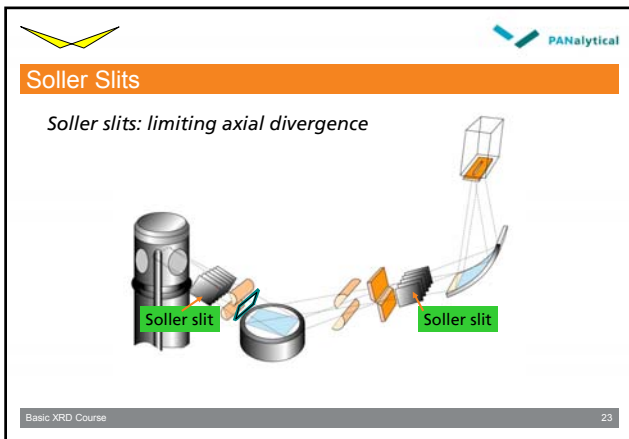
*Tube focus and receiving slit:
determining instrument resolution*



receiving slit

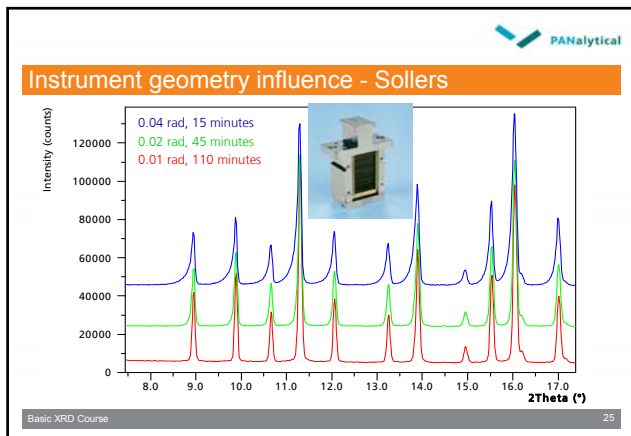
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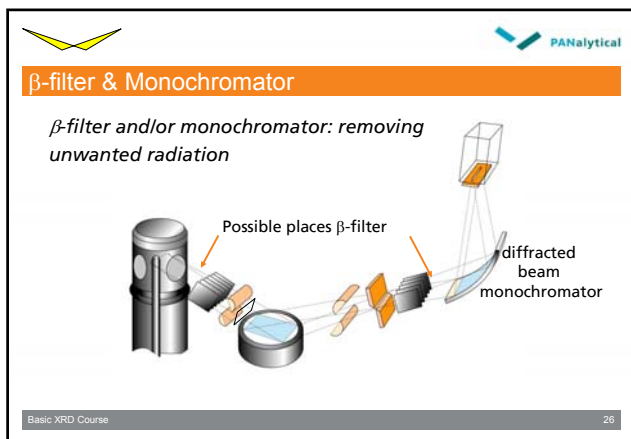




-
- Soller Slits**
- Soller slits consist of large numbers of parallel plates in the plane of diffraction.
 - Soller slits limit the spread of the incident and diffracted X-ray beam out of the plane of diffraction: 0.01, 0.02, 0.04 and 0.08 rad.
 - large effect on intensities
 - moderate effect on resolution (low/high 2θ)
 - It is good practice to place similar Soller slits in the incident and diffracted beam.
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-
- β -filter & Monochromator**
- The β -filter and the diffracted beam monochromator remove unwanted wavelengths like the $K\beta$ -line and continuous radiation.
 - The β -filter selectively absorbs radiation.
 - Monochromators select radiation by means of diffraction.
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β -filter & Monochromator

Use filter material with absorption edge in between $K\alpha$ and $K\beta$ line.

For example:
Cu-radiation

Ni filter

- Intensity Cu $K\alpha$: 50 %
- Intensity Cu $K\beta$: 1%

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β -filter & Monochromator

Only X-ray waves with correct wavelength pass the entrance slit of the detector.

Others do not focus in the entrance slit of the detector.

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Diffracted Beam Monochromator

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β-filter & Monochromator

The symmetrically cut curved Ge(111) monochromator in combination with the divergence slit filters out the $K\alpha_2$ component leaving a beam with $K\alpha_1$ radiation only.

Curved Ge(111) *incident* beam monochromator

line focus X-ray tube

$K\alpha_2$

$K\alpha_1$

divergence slit

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Incident Beam Monochromator

Irradiation slit

X-ray tube (line focus)

Incident beam monochromator

Programmable divergence slit

Soller slits

Polycrystalline sample

Anti scatter slit

Receiving slit

Detector

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Sample Stages

Displacement error:

Sample stage and/or sample above or below diffraction plane: peaks are displaced from original position by

$$\Delta 2\theta = \frac{2s \cos \theta}{R}$$

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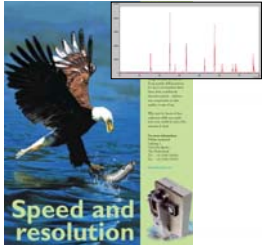
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X'Celerator Optics

Getting the best out of your X'Celerator detector

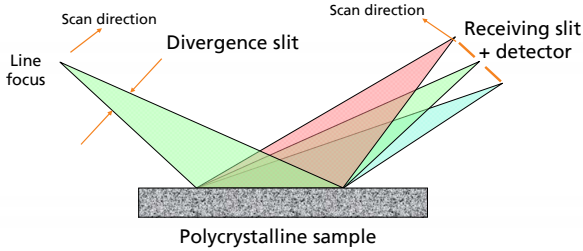


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What is RTMS Technology? (1)

Classical geometry (Bragg-Brentano)



Line focus

Scan direction

Divergence slit

Scan direction

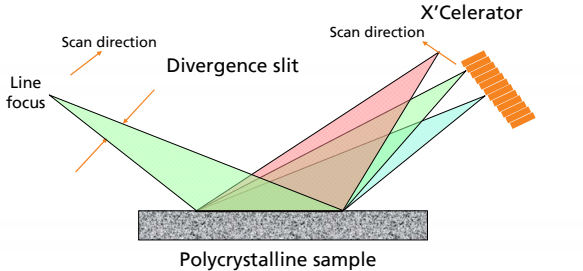
Receiving slit + detector

Polycrystalline sample

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What is RTMS Technology? (2)



Line focus

Scan direction

Divergence slit

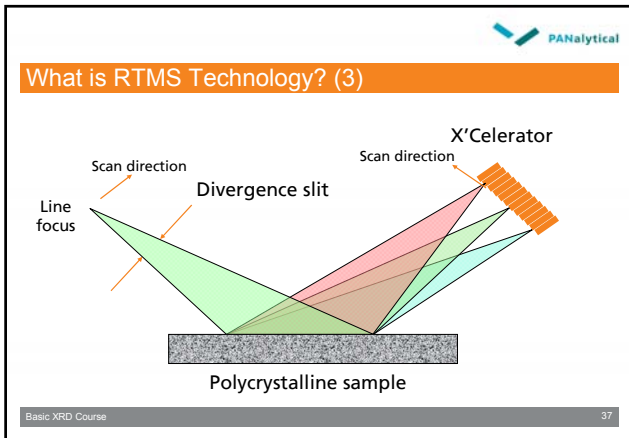
Scan direction

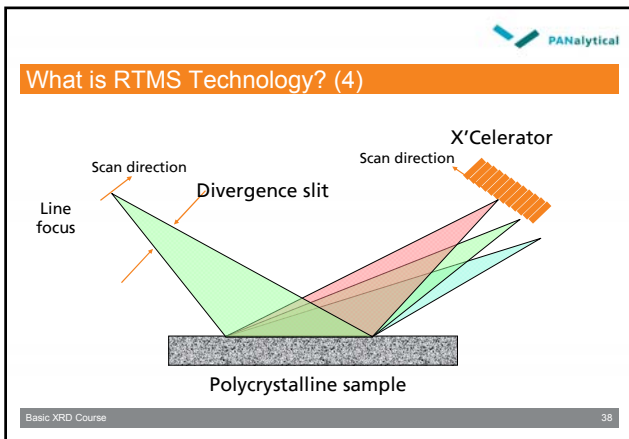
X'Celerator

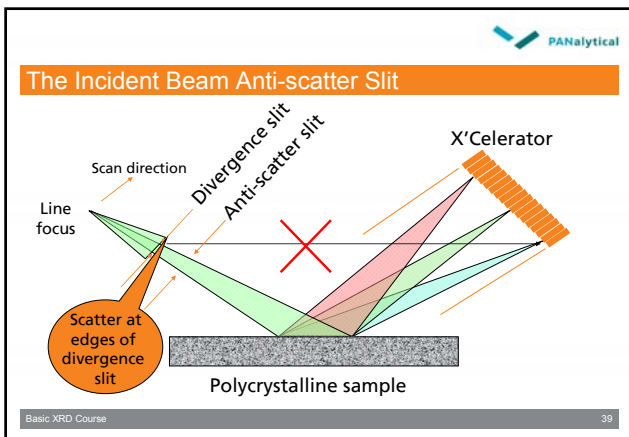
Polycrystalline sample


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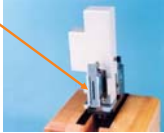







The Incident Beam Anti-scatter Slit

Divergence slit size	Anti-scatter slit size
1/32°	1/16°
1/16°	1/8°
1/8°	1/4°
1/4°	1/2°
1/2°	1°
1°	2°
2°	4°
4°	-

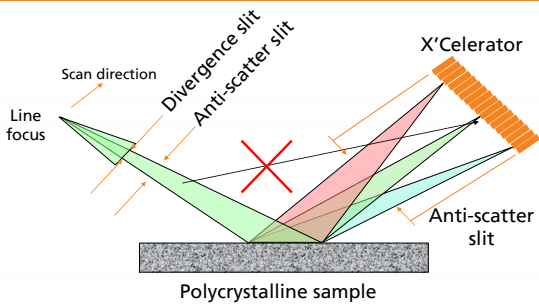


- So: 1° divergence slit → 2° inc. beam anti-scatter slit


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The Diffracted Beam Anti-scatter Slit




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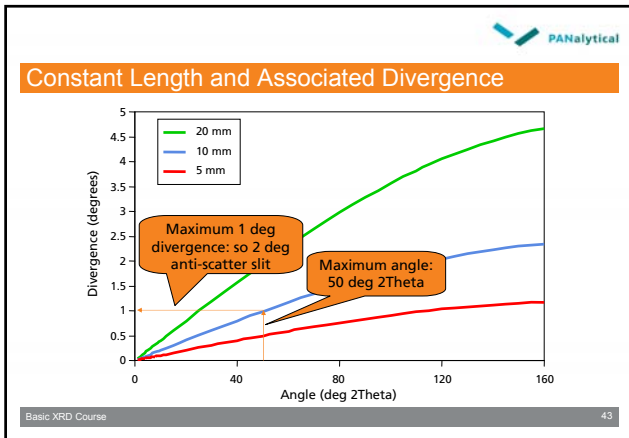
The Programmable Anti-scatter Slit

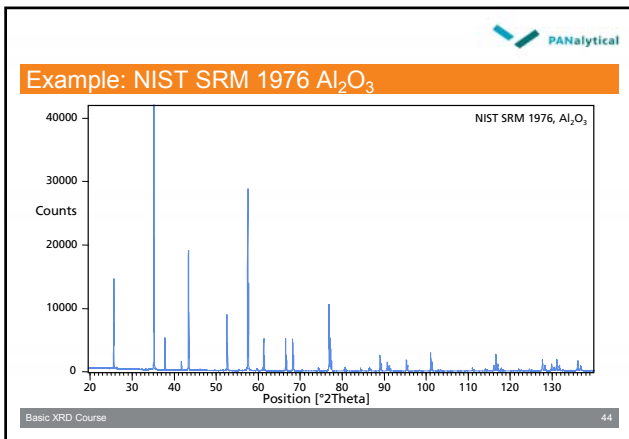
- Two modes of operation:
 - constant observed length
 - constant observed angle
- Can be changed at will
- Actual opening is also a function of the active length of the X'Celerator: important when working at low angles!

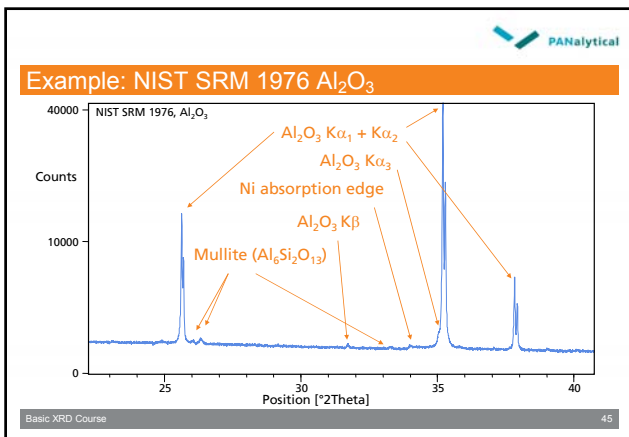



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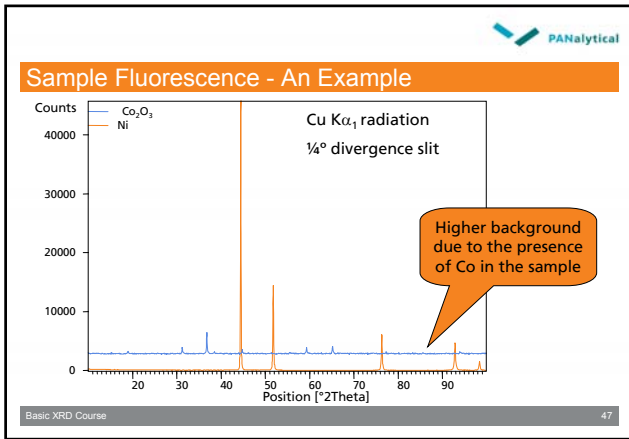


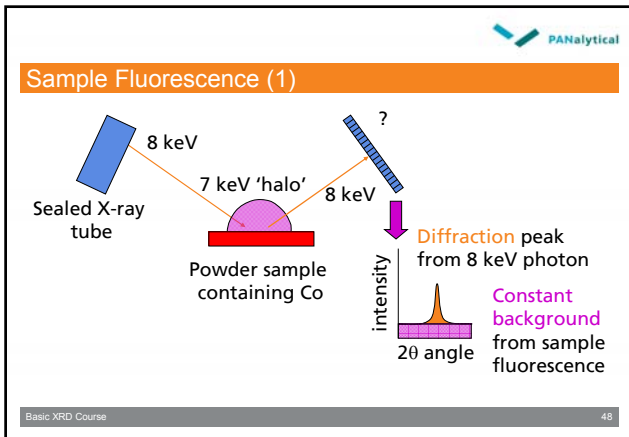



Sample Fluorescence

- X-rays excite the atoms in the sample
- As a result of this, characteristic X-radiation is emitted
- If this emitted radiation is close to the Cu $K\alpha$, it is detected!

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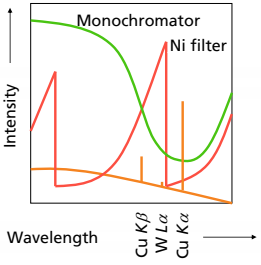







The Monochromator

- Crystal which acts as band pass filter



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Rules of Thumb - Monochromators

- Monochromators help to reduce the range of problematic elements

Cu, inc. beam mono	Sc	Ti	V	Cr	Mn	Fe	Co	Ni	Cu	Zn	Ga	Ge	As
Cu, dif. beam mono	Sc	Ti	V	Cr	Mn	Fe	Co	Ni	Cu	Zn	Ga	Ge	As
Co, inc. beam mono	Sc	Ti	V	Cr	Mn	Fe	Co	Ni	Cu	Zn	Ga	Ge	As
Co, dif. beam mono	Sc	Ti	V	Cr	Mn	Fe	Co	Ni	Cu	Zn	Ga	Ge	As

low high


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Rules of Thumb - Beta Filters

- β -filters: more background, but least reduction of $K\alpha$
- For best results, the β -filter should be placed in the diffracted beam
 - exceptions: Ni with Cu radiation, Fe with Co(!)
- For not-too-complex patterns, Mo radiation is a valuable alternative

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Rules of Thumb - Continued

- When going from Cu to Co radiation...
 - *the peak intensities drop with a factor of about 3...*
 - *exception: Fe and Co samples: there the intensity rises with a factor of 3!*
- Effect of varying penetration depth when absorption edges of elements in the sample are close to the characteristic radiation

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